Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/644,841	Reexamination MAYER ET AL.	
Examiner	Art Unit	
RENIAMINE LANIER	2432	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0143845	10-2002	Kardach, James P.	709/102
*	В	US-2001/0034847	10-2001	Gaul,Jr., Stephen E.	713/201
*	С	US-6,357,008	03-2002	Nachenberg, Carey S.	726/24
*	D	US-5,675,520	10-1997	Pitt et al.	703/23
*	Е	US-6,240,530	05-2001	Togawa, Yoshifusa	714/38
*	F	US-5,425,102	06-1995	Moy, Michael E.	713/183
*	G	US-6,813,712	11-2004	Luke, James Steven	726/24
*	Н	US-5,944,821	08-1999	Angelo, Michael F.	726/22
*	Т	US-2002/0065869	05-2002	Calder et al.	709/201
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U		
	v		
	w		
	x		

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.